



<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10628261	KITAMURA, MAMORU
	Examiner Lee, Siu M	Art Unit 2611

Notes	Date	Examiner
	10/4/2006	Siu M. Lee
US-PGPUB	10/4/2006	Siu M. Lee
USPAT	10/4/2006	Siu M. Lee
USOCR	10/4/2006	Siu M. Lee
EPO	10/4/2006	Siu M. Lee
JPO	10/4/2006	Siu M. Lee
DERWENT	10/4/2006	Siu M. Lee
IEEE	10/4/2006	Siu M. Lee
GOOGLE	10/4/2006	Siu M. Lee
Discuss the application with Chieh Fan	10/11/2006	Siu M. Lee
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<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10628261</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KITAMURA, MAMORU</p>
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Class	SubClass	Date	Examiner
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330	251, 253, 259, 260, 264, 265, 269, 271, 277	10/4/2006	Siu M. Lee
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329	312	10/4/2006	Siu M. Lee
398	191	10/4/2006	Siu M. Lee
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